


<b>Search Notes</b>  	<b>Application/Control No.</b>  10510907	<b>Applicant(s)/Patent Under Reexamination</b>  HOGBERG ET AL.
	<b>Examiner</b>  Loewe, Sun Jae Y	<b>Art Unit</b>  1609

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
STN Structure	6/5/2007	SL
PALM Inventor (all inventors)	6/5/2007	SL
stn: registry & caplus (updated)	2-11-2008	sl
palm all inventors (updated)	2-11-2008	sl

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner